

Testing mass production ladders with a radiation source

It's good to define the procedures

- **Radiation source:** ^{90}Sr
- **Ladders to be tested:** all? some of them?
- **Cables:** with a bus extender?
- **How do we test? (1):** with the source test fixture or the dark box?
- **How do we test? (2):** β -ray exposure by setting a source below a ladder (center of the sides, center of 2 chips) for 10 min?
- **How do we test? (3):** what about DAC configuration?
- **We do noise measurement, right?:** by setting low DAC0 value (8? 15?) without a source

it may depends
on the intensity
of the source

